

Application/Control No.	Applicant(s)/Patent un Reexamination	Applicant(s)/Patent under Reexamination	
10/535,419	SHIRAKAWA ET AL.		
Examiner	Art Unit		
Connadiy Mach	1711		

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOT (INCLUDING SEARCH	ES STRATEGY)
	DATE	EXMR
Updated	7/19/2007	GM